



G2316B

Microcircuits

NMOS 2048 X 8 ROM

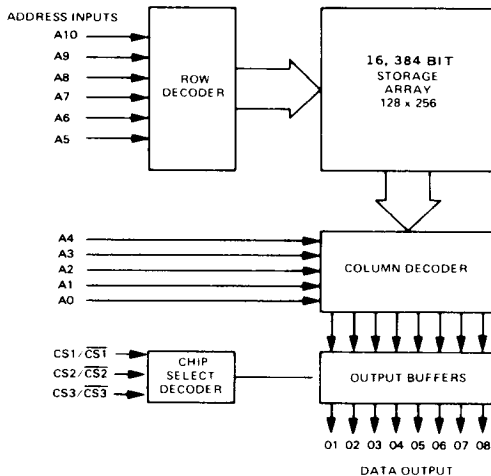
Features

- 2048 8-bit bytes (16K)
- Maximum Active Current: 100 mA
- Max. access time: 350 nS—G2316B—3
450 nS—G2316B—4
- Output drive: one TTL load, plus 100 pF
- All input/outputs TTL compatible
- Three programmable Chip Select inputs
- Three-state outputs for memory expansion
- Single +5V power supply, ± 5 percent
- Standard 24-pin plastic or cerdip package

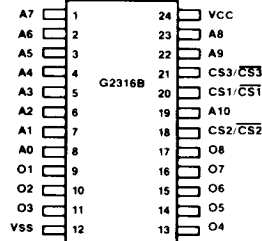
General Description

The GTE G2316B Read Only Memory is a 2048 word by 8 bit device with a maximum access time of 350 nanoseconds or 450 nanoseconds. The G2316B ROM is a mask-programmable, byte-organized memory designed for use in bus-oriented applications with all 8-bit N-channel microprocessors. Three Chip Select inputs provide convenient memory expansion—allowing up to 8 G2316B ROMs to be OR-tied without external coding. In addition, three-state output buffers allow simple parallel-busing for memory expansion. The G2316B is TTL compatible, requires only a single +5V power supply, no external clocks and no refresh circuitry. Packaging is standard 24-pin plastic or cerdip.

Block Diagram



Pin Configuration



Pin Function

Pin	Description
A0-A10	Address
O1-O8	Outputs
VCC	+5V
VSS	Ground
CS	Chip Select

Ordering Information

Device	Access Time (nS)	Max. Active Current (mA)	Package	Temp. Range
G2316B-3CJ	350	100	Cerdip	0°C to 70°C
G2316B-3CK	350	100	Plastic	0°C to 70°C
G2316B-4CJ	450	100	Cerdip	0°C to 70°C
G2316B-4CK	450	100	Plastic	0°C to 70°C

Absolute Maximum Ratings: (Note 1)

Parameter	Symbol	Value
Voltage to Any Pin With Respect to V _{SS}	V _{DC}	0.5V to 7.0V
Current Into/From Output	I _{DD}	50 mA
Operation Ambient Temp. Range	T _A	0°C to 70°C
Storage Temp. Range	T _S	-65°C to 150°C

This device contains input protection against damage due to high static voltages or electric fields; however, precautions should be taken to avoid application of voltages higher than the maximum ratings.

NOTES:

- Exceeding these ratings may cause permanent damage, functional operation under these conditions is not implied.

DC Electrical Characteristics: Full Operating Voltage and Temperature Range

Characteristic	Symbol	Min	Max	Unit	Conditions
Input High Level	V _{IH}	2.0	V _{CC}	V	
Input Low Level	V _{IL}	-0.5	+0.8	V	
Input Leakage Current	I _{LI}	-10	+10	μA	
I/O Leakage Current	I _{LO}	-10	+10	μA	V _O = 0.4 to V _{CC}
Output Voltage High	V _{OH}	2.4	—	V	I _O = -0.2 mA
Output Voltage Low	V _{OL}	—	0.4	V	I _O = 2.1 mA
Power Supply Current	I _{CC}	—	100	mA	V _{CC} = 5.25, T _A = 0°C

Read Cycle—AC Characteristics: Full Operating Voltage and Temperature Range

Parameter	Symbol	G2316B-3		G2316B-4		Units
		Min	Max	Min	Max	
Read Cycle Time	t _{RC}	350	—	450	—	nS
Address Access Time	t _{AA}	—	350	—	450	nS
Chip Select Delay Time	t _{CD}	—	120	—	150	nS
Chip Deselect Delay Time	t _{DF}	—	120	—	150	nS
Data Valid After Address Change	t _{OH}	20	—	20	—	nS

Capacitance

Parameter	Symbol	Typ	Max	Unit	Conditions
Input Capacitance	C _{IN}	4	7	pF	
Output Capacitance	C _{OUT}	5	10	pF	V _O = 0V

Timing Diagram